## Issue Classification | 10696051



Application/Control	No.

Examiner

Applicant(s)/Patent Under Reexamination

CHEN, SU

Art Unit

DAVID WEISZ 1777

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/DAVID WEISZ/ Examiner.Art Unit 1777 (Assistant Examiner)	4/21/11 (Date)	Total Claims Allowed:			
/Yelena G Gakh, Ph.D./ Primary Examiner.Art Unit 1777	04/21/2011	O.G. Print Claim(s)	O.G. Print Figure		
(Primary Examiner)	(Date)	1	1		